

L Number	Hits	Search Text	DB	Time stamp
16	68	29/840 and insulative with film	USPAT	2004/10/22 13:24
17	13	wafer with testing and subset with contact	USPAT	2004/10/22 13:31
18	2	wafer with testing and subset with contacts	USPAT	2004/10/22 13:34
19	7	die with testing and subset with terminals	USPAT	2004/10/22 13:37
20	5	dice with testing and subset with terminals	USPAT	2004/10/22 13:37
21	3	324/763 and subset with terminals	USPAT	2004/10/22 13:38
22	1	29/\$ and subset with terminals and die with testing	USPAT	2004/10/22 13:42
23	1		USPAT	2004/10/22 13:39
24	7	subset with terminals and die with testing	USPAT	2004/10/22 13:43
25	0	subset with terminals with film and testing	USPAT	2004/10/22 13:44
26	21	selected with terminals with film and testing	USPAT	2004/10/22 13:47
27	0	subgroup with terminals with film and testing	USPAT	2004/10/22 13:48
28	0	subgroup with terminals with film and test	USPAT	2004/10/22 13:48
29	0	subset with terminals with film and test	USPAT	2004/10/22 13:49
30	0	subset with terminals with film and die	USPAT	2004/10/22 13:49
-	0	439/148.ccls. and insulative adj cover	USPAT	2004/05/05 18:28
-	0	439/148.ccls. and insulative with probe	USPAT	2004/05/05 18:29
-	1	439/148.ccls. and probe	USPAT	2004/05/05 18:29
-	118	439/148.ccls.	USPAT	2004/05/05 18:32
-	55	"5974662"	USPAT	2004/05/05 18:35
-	6160	probe with testing	USPAT	2004/05/05 18:47
-	669	probe adj card with testing	USPAT	2004/05/05 18:38
-	6	(probe adj card with testing) and select with terminal	USPAT	2004/05/05 18:41
-	3	(probe adj card with testing) and terminal with (epoxy)	USPAT	2004/05/05 18:42
-	0	(probe adj card with testing) and terminal with (nylon)	USPAT	2004/05/05 18:43

-	0	(probe adj card with testing) and terminal with (starch)	USPAT	2004/05/05 18:43
-	0	(probe adj card with testing) and terminal with (vinyl)	USPAT	2004/05/05 18:43
-	0	(probe adj card with testing) and terminal with (polyethylene)	USPAT	2004/05/05 18:44
-	0	(probe adj card with testing) and terminal with (polypropylene)	USPAT	2004/05/05 18:44
-	6	(probe adj card with testing) and terminal with (rubber)	USPAT	2004/05/05 18:46
-	3	(probe adj card with testing) and terminal with insulative	USPAT	2004/05/05 18:47
-	0	(probe adj card with testing) and terminal with dummy	USPAT	2004/05/05 18:47
-	0	probe with card same testing and terminal with dummy	USPAT	2004/05/05 18:48
-	0	probe with card same testing and terminal same dummy	USPAT	2004/05/05 18:48
-	1	probe with card same testing and terminals same dummy	USPAT	2004/05/05 18:50
-	1	probe with card same testing and terminals same unused	USPAT	2004/05/05 18:50
-	312	probe with card same testing and terminals	USPAT	2004/05/05 18:50
-	13	probe with card same testing and terminals and dummy	USPAT	2004/05/05 19:07
-	6	probe with card same testing and terminals and unused	USPAT	2004/05/05 19:07
-	0	probe with card same terminals with dummy	USPAT	2004/05/06 09:54
-	273	probe with card same terminals	USPAT	2004/05/06 11:57
-	0	probe with card same terminals with insulative	USPAT	2004/05/06 10:44
-	0	probe with card same terminals same insulative	USPAT	2004/05/06 10:45
-	4	probe with card and terminals same insulative	USPAT	2004/05/06 10:46
-	19	probe with card and contacts same insulative	USPAT	2004/05/06 10:58
-	9	probe with card and contacts and Insulative adj film	USPAT	2004/05/06 11:00
-	2	probe with card and terminals and Insulative adj film	USPAT	2004/05/06 11:02
-	0	probe and terminals and insulative adj film same selectively	USPAT	2004/05/06 11:02
-	17	probe and terminals and insulative adj film and selectively	USPAT	2004/05/06 11:09
-	10	probe and terminals and insulative adj film and selective	USPAT	2004/05/06 11:09
-	10	insulative with covering and probe with tips	USPAT	2004/05/06 11:23

-	0	probe with card same terminals with (subset or subgroup)	USPAT	2004/05/06 11:58
-	5	probe with card and terminals with (subset or subgroup)	USPAT	2004/05/06 11:58
-	0	439/148.ccls. and insulative with tip	USPAT	2004/06/25 12:07
-	66	439/\$.ccls. and insulative with tip	USPAT	2004/06/25 12:08
-	66	439/\$.ccls. and insulative with tip	USPAT	2004/06/25 12:09
-	3	439/\$.ccls. and Insulative with tip with cover	USPAT	2004/06/25 12:10
-	1	439/\$.ccls. and insulative with tip with film	USPAT	2004/06/25 12:11
-	3	probe and insulative with tip with film	USPAT	2004/06/25 12:13
-	1	probe and insulative with tips with film	USPAT	2004/06/25 12:13
-	772	439/66.ccls.	USPAT	2004/06/25 12:16
-	9	439/66.ccls. and insulative with film	USPAT	2004/06/25 12:19
-	24	439/\$.ccls. and (contacts or tips) with selectively with exposed	USPAT	2004/06/25 12:20
-	24	439/\$.ccls. and (contacts or tips) with selectively with exposed	USPAT	2004/06/25 12:24
-	1	439/\$.ccls. and (contacts or tips) with selectively with exposed with insulative	USPAT	2004/06/25 12:25
-	0	324/\$.ccls. and (contacts or tips) with selectively with exposed with insulative	USPAT	2004/06/25 13:06
-	0	324/\$.ccls. and (contacts or tips) with selectively with exposed and insulative	USPAT	2004/06/25 12:26
-	0	324/\$.ccls. and probe and tips with selectively with exposed and insulative	USPAT	2004/06/25 12:26
-	2	324/\$.ccls. and probe and tips with selectively with exposed	USPAT	2004/06/25 12:29
-	1	324/\$.ccls. and probe and tips with subset	USPAT	2004/06/25 12:31
-	1	324/\$.ccls. and probe and tips with subset	USPAT	2004/06/25 12:33
-	56	"5974662"	USPAT	2004/06/25 12:35
-	4	"5974662" and insulative with film	USPAT	2004/06/25 12:38
-	4	probing with system and subset with probes	USPAT	2004/06/25 12:44
-	0	probing with device and subset with probes	USPAT	2004/06/25 12:45
-	0	probing with device and subset with bumps	USPAT	2004/06/25 12:45
-	17	subset with bumps	USPAT	2004/06/25 12:50

-	0	desabling with probes	USPAT	2004/06/25 12:52
-	0	desable with probes	USPAT	2004/06/25 12:51
-	0	desable with probe	USPAT	2004/06/25 12:51
-	178	disable with probe	USPAT	2004/06/25 12:51
-	24	disabling with probes	USPAT	2004/06/25 12:52
-	6	disabling with probes and 324/\$.ccls.	USPAT	2004/06/25 12:54
-	5706	probes and 324/\$.ccls.	USPAT	2004/06/25 12:54
-	9964	probe and 324/\$.ccls.	USPAT	2004/06/25 12:54
-	1	probe and 324/\$.ccls. and probes with insulative with covering	USPAT	2004/06/25 12:55
-	379	probe and 324/\$.ccls. and probes with selected with probes	USPAT	2004/06/25 12:56
-	0	probe and 324/\$.ccls. and probes with selected with probes and insulative with film	USPAT	2004/06/25 12:57
-	19	probe and 324/\$.ccls. and probes with selected with probes and insulative	USPAT	2004/06/25 12:57
-	19	probe and 324/\$.ccls. and probes with selected with probes and insulative	USPAT	2004/06/25 13:00
-	0	324/\$.ccls. and probes with disabling with insulative with film	USPAT	2004/06/25 13:00
-	0	324/\$.ccls. and probe with disabling with insulative with film	USPAT	2004/06/25 13:01
-	0	probe with disabling with insulative with film	USPAT	2004/06/25 13:01
-	0	324/\$.ccls. and probes with disabling with insulative with film	USPAT	2004/06/25 13:01
-	0	324/\$.ccls. and probes with disabled with insulative with film	USPAT	2004/06/25 13:01
-	0	324/\$.ccls. and probe with disabled with insulative with film	USPAT	2004/06/25 13:01
-	0	probe with disabled with insulative with film	USPAT	2004/06/25 13:01
-	0	probes with disabled with insulative with film	USPAT	2004/06/25 13:02
-	0	probes same disabled with insulative with film	USPAT	2004/06/25 13:02
-	0	probes same disabled same Insulative with film	USPAT	2004/06/25 13:02
-	0	bumps same disabled same Insulative with film	USPAT	2004/06/25 13:03
-	51	bumps same insulative with film	USPAT	2004/06/25 13:03
-	30	bumps same insulative with film and selected	USPAT	2004/06/25 13:04

-	0	324/\$.ccls. and (contacts or tips) same selectively with exposed with insulative	USPAT	2004/06/25 13:07
-	0	324/\$.ccls. and (probes) same selectively with exposed with insulative	USPAT	2004/06/25 13:07
-	4	324/\$.ccls. and (probes) same selectively with exposed	USPAT	2004/06/25 13:09
-	139	324/\$.ccls. and probes and disabling	USPAT	2004/06/25 13:09
-	6	324/\$.ccls. and probes with disabling	USPAT	2004/06/25 13:13
-	12	324/\$.ccls. and probes same disabling	USPAT	2004/06/25 13:16
-	7	324/\$.ccls. and probe with card same disabling	USPAT	2004/06/25 13:22
-	3	324/\$.ccls. and testing with chip and terminals same disabling	USPAT	2004/06/25 13:19
-	15	324/\$.ccls. and probe and contacts same disabling	USPAT	2004/06/25 13:25
-	18	probe and (contacts or terminals or bumps or probes) same disabling same selectively	USPAT	2004/06/25 13:28
-	26	probe and (contacts or terminals or bumps or probes) same (insulative with covering)	USPAT	2004/06/25 13:29
-	3	probe and (contacts or terminals or bumps or probes) same (insulative with covering) and 324/\$.ccls.	USPAT	2004/06/25 13:30
-	13	probe and (contacts or terminals or bumps or probes) same (insulative with film) and 324/\$.ccls.	USPAT	2004/06/25 13:31
-	13	probe and (contacts or terminals or bumps or probes) same (insulative with film) and 324/\$.ccls.	USPAT	2004/06/25 13:43
-	222	probe and (contacts or terminals or bumps or probes) and (insulative with material) and 324/\$.ccls.	USPAT	2004/06/25 13:44
-	17	probe and (contacts or terminals or bumps or probes) with (insulative with material) and 324/\$.ccls.	USPAT	2004/06/25 13:44
-	17	probe and (contacts or terminals or bumps or probes) with (insulative with material) and 324/\$.ccls.	USPAT	2004/06/25 14:03
-	20	"5831441"	USPAT	2004/06/25 14:21
-	1	"5634267".PN.	USPAT	2004/06/25 14:08
-	1	"5604445".PN.	USPAT	2004/06/25 14:08
-	1	"5374893".PN.	USPAT	2004/06/25 14:09
-	1	"5326428".PN.	USPAT	2004/06/25 14:09
-	1	"20040002264"	USPAT; US-PGPUB	2004/06/25 14:21